

Notice of References Cited

Application/Control No.

10/529,355

Applicant(s)/Patent Under
Reexamination
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Examiner

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Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1 168 651 A2	01-2002	JP	Gunji, Hiroshi	H04B 1/66
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NON-PATENT DOCUMENTS

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